Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
09/718,155	HAYASHI, KOJI
Examiner	Art Unit
TAN X. DINH	2627

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
Interference Search History Printout		9/21/2006	T.D		

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DATE	EXMR
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